

Search Notes

Application/Control No.

10/606,396

Examiner

Thien F. Tran

Applicant(s)/Patent under
Reexamination

GERMAIN ET AL.

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
257	676	1/11/2005	TT
257	782-784	1/11/2005	TT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR